TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VHCT245AF,TC74VHCT245AFW,TC74VHCT245AFT,TC74VHCT245AFK

Octal Bus Transceiver

The TC74VHCT245A is an advanced high speed CMOS OCTAL BUS TRANSCEIVER fabricated with silicon gate C²MOS technology. It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

It is intended for two-way asynchronous communication between data busses. The direction of data transmission is determined by the level of the DIR input.

The enable input (\overline{G}) can be used to disable the device so that the busses are effectively isolated.

The input voltage are compatible with TTL output voltage.

This device may be used as a level converter for interfacing $3.3\ V$ to $5\ V$ system.

Input protection and output circuit ensure that 0 to 5.5 V can be applied to the input and output $^{\rm (Note)}$ pins without regard to the supply voltage. These structure prevents device destruction due to mismatched supply and input/output voltages such as battery back up, hot board insertion, etc.

Note: Output in off-state

Features (Note)

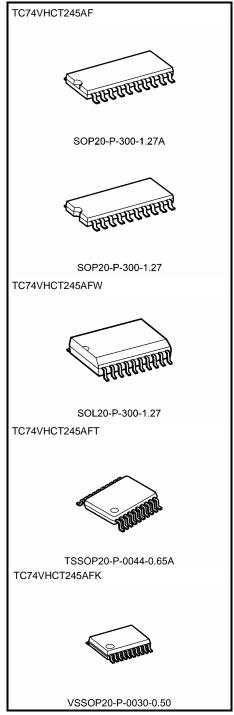
- High speed: $t_{pd} = 4.9 \text{ ns (typ.)}$ at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $ICC = 4 \mu A \text{ (max)}$ at $Ta = 25^{\circ}C$
- Compatible with TTL outputs: $V_{IL} = 0.8 \ V \ (max)$ $V_{IH} = 2.0 \ V \ (min)$
- · Power down protection is provided on all inputs and outputs
- Balanced propagation delays: t_pLH ≃ t_pHL
- Low noise: VOLP = 1.6 V (max)
- Pin and function compatible with the 74 series (74AC/HC/F/ALS/LS etc.) 245 type.

Note: Do not apply a signal to any bus terminal when it is in the output mode. Damage may result.

All floating (high impedance) bus terminals must have their input levels fixed by means of pull up or pull down resistors.

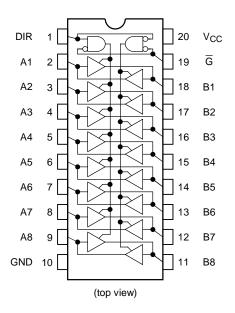
Weight

SOP20-P-300-1.27A : 0.22 g (typ.) SOP20-P-300-1.27 : 0.22 g (typ.) SOL20-P-300-1.27 : 0.46 g (typ.) TSSOP20-P-0044-0.65A : 0.08 g (typ.) VSSOP20-P-0030-0.50 : 0.03 g (typ.) Note: xxxFW (JEDEC SOP) is not available in Japan.

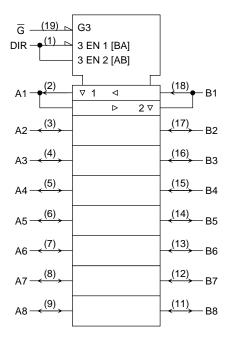




Pin Assignment



IEC Logic Symbol



Truth Table

Inputs		Fund	Output		
G	DIR	A Bus	B Bus	Output	
L	L	Output	Input	A = B	
L	Н	Input Output		B = A	
Н	Х	Ž	Z		

X: Don't care

Z: High impedance



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit	
Supply voltage range	Vcc	-0.5 to 7.0	V	
DC input voltage (DIR, \overline{G})	V _{IN}	-0.5 to 7.0	V	
DC bus I/O voltage	Vivo	-0.5 to 7.0 (Note 2)	V	
DC bus 1/O voltage	V _{I/O}	-0.5 to V _{CC} + 0.5 (Note 3)	V	
Input diode current	I _{IK}	-20	mA	
Output diode current	lok	±20 (Note 4)	mA	
DC output current	lout	±25	mA	
DC V _{CC} /ground current	Icc	±75	mA	
Power dissipation	PD	180	mW	
Storage temperature	T _{stg}	-65 to 150	°C	

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Note 2: Output in off-state

Note 3: High or low state. $I_{\mbox{OUT}}$ absolute maximum rating must be observed.

Note 4: $V_{OUT} < GND$, $V_{OUT} > V_{CC}$

Recommended Operating Conditions (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage	V _{CC}	4.5 to 5.5	V
Input voltage (DIR, G)	V _{IN}	0 to 5.5	V
Bus I/O voltage	Vuo	0 to 5.5 (Note 2)	V
Bus I/O voltage	V _{I/O}	0 to V _{CC} (Note 3)	V
Operating temperature	T _{opr}	-40 to 85	°C
Input rise and fall time	dt/dV	0 to 20	ns/V

Note 1: The recommended operating conditions are required to ensure the normal operation of the device.

Unused inputs must be tied to either VCC or GND.

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Note 2: Output in off-state

Note 3: High or low state



Electrical Characteristics

DC Characteristics

Characteristics	Symbol		Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit
	-,	V		V _{CC} (V)	Min	Тур.	Max	Min	Max	
High-level input voltage	V _{IH}	_		4.5 to 5.5	2.0	_	_	2.0	_	V
Low-level input voltage	V _{IL}		_	4.5 to 5.5	_	_	0.8	_	0.8	V
High-level output	.,	V _{IN}	$I_{OH} = -50 \mu A$	4.5	4.4	4.5	_	4.4	_	V
voltage	Voн	= V _{IH} or V _{IL}	$I_{OH} = -8 \text{ mA}$	4.5	3.94	_	_	3.80	_	
Low-level output	V _{OL}	V _{IN} = V _{IH} or V _{IL}	$I_{OL} = 50 \mu A$	4.5		0.0	0.1	_	0.1	V
voltage			I _{OL} = 8 mA	4.5	_	_	0.36		0.44	
3-state output off-state current	I _{OZ}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = V_{CC}$ or GND		5.5	_	_	±0.25	_	±2.50	μА
Input leakage current	I _{IN}	V _{IN} = 5.5 V or GND		0 to 5.5	_	_	±0.1	_	±1.0	μА
	Icc	V _{IN} = V _{CC} or GND		5.5	_	_	4.0	_	40.0	μА
Quiescent supply current	Ісст	Per input: V _{IN} = 3.4 V Other input: V _{CC} or GND		5.5	_	_	1.35		1.50	mA
Output leakage current	I _{OPD}	V _{OUT} = 5.5 V		0	_	_	0.5	_	5.0	μА

AC Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit	
	,		V _{CC} (V)	C _L (pF)	Min	Тур.	Max	Min	Max	
Propagation delay	t _{pLH}		5.0 ± 0.5	15		4.9	7.7	1.0	8.5	ns
time	t _{pHL}			50	_	5.4	8.7	1.0	9.5	
3-state output enable	t_{pZL}	$R_L = 1 \text{ k}\Omega$	5.0 ± 0.5	15		9.4	13.8	1.0	15.0	ns
time	t _{pZH}			50	_	9.9	14.8	1.0	16.0	115
3-state output disable	t _{pLZ}	$R_L = 1 \text{ k}\Omega$	5.0 ± 0.5	50		10.1	15.4	1.0	16.5	ns
time	t _{pHZ}			50		10.1	10.4	1.0	10.0	110
Output to output skew	t _{osLH}	(Note 1)	5.0 ± 0.5	50	_	_	1.0	_	1.0	ns
Output to output onow	t _{osHL}	(11010-1)	0.0 ± 0.0	0			1.0		1.0	110
Input capacitance	C _{IN}	DIR, G			_	4	10	_	10	pF
Bus input capacitance	C _{I/O}	An, Bn		·		13			_	pF
Power dissipation capacitance	C _{PD}			(Note 2)	_	16	_	_	_	pF

Note 1: Parameter guaranteed by design.

$$t_{\text{OSLH}} = |t_{\text{pLHm}} - t_{\text{pLHn}}|, \, t_{\text{OSHL}} = |t_{\text{pHLm}} - t_{\text{pHLn}}|$$

Note 2: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

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Average operating current can be obtained by the equation:

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per bit)}$$



Noise Characteristics (input: $t_r = t_f = 3$ ns) (Note)

Characteristics	Symbol	Test Condition		Ta = 25°C		Unit
Characteristics	Symbol		V _{CC} (V)	Тур.	Limit	Offic
Quiet output maximum dynamic V _{OI}	V _{OLP}	C _I = 50 pF	5.0	1.1	1.5	V
Quiet output maximum dynamic VOL	VOLP	Ο[– 30 μι		(1.2)	(1.6)	
Quiet output minimum dynamic V _{OI}	V _{OLV}	$C_1 = 50 \text{ pF}$	5.0	-1.1	-1.5	V
Quiet output minimum dynamic Vol		Ο <u>Γ</u> = 00 βι		(-1.2)	(-1.6)	
Minimum high level dynamic input voltage	V_{IHD}	C _L = 50 pF	5.0	_	2.0	V
Maximum low level dynamic input voltage	V _{ILD}	C _L = 50 pF	5.0	_	0.8	V

Note: The value in () only applies to JEDEC SOP (FW) devices.

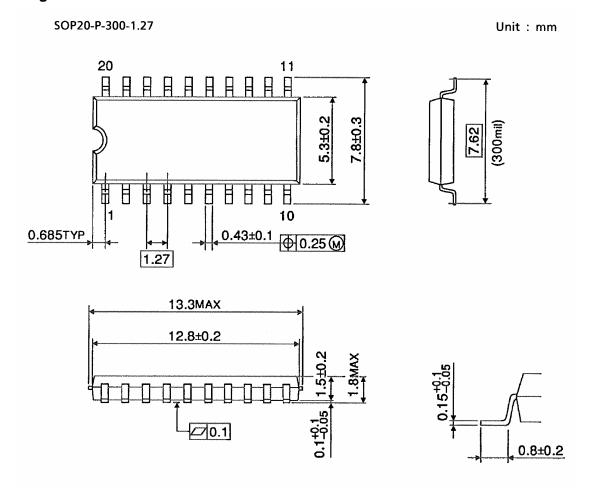
SOP20-P-300-1.27A

Unit: mm

20
11
127
0.685TYP
13.3MAX
12.8 ± 0.2

Weight: 0.22 g (typ.)



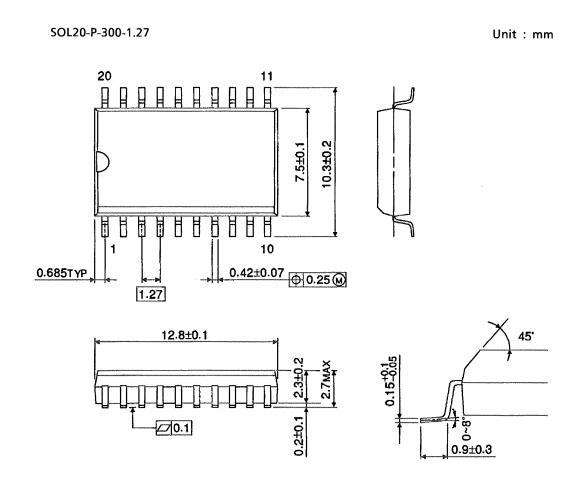


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Weight: 0.22 g (typ.)



Package Dimensions (Note)



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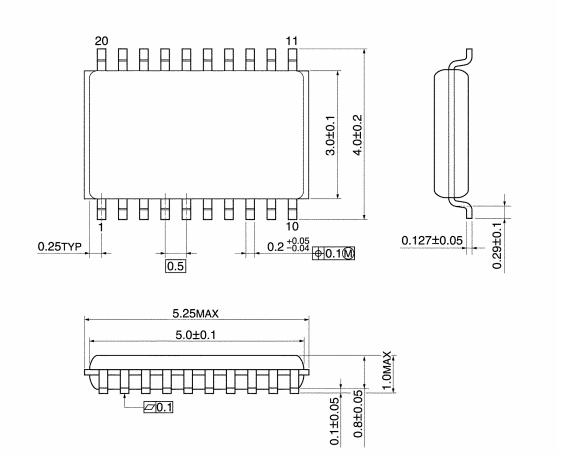
Note: This package is not available in Japan.

Weight: 0.46 g (typ.)

TSSOP20-P-0044-0.65A Unit: mm 6.4±0.2 $0.22\substack{+0.09 \\ -0.06}$ 0.65 0.325TYP **⊕**0.13**M** 6.9MAX 6.5±0.1 1.2MAX 0.15 +0.03 0~10 1.0±0.05 0.1±0.05 S Ø.1|S (0.5)0.45~0.75

Weight: 0.08 g (typ.)

VSSOP20-P-0030-0.50 Unit: mm



Weight: 0.03 g (typ.)



Note: Lead (Pb)-Free Packages

SOP20-P-300-1.27A TSSOP20-P-0044-0.65A VSSOP20-P-0030-0.50

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